# $\gamma/\varphi_3$ Impact from CLEO-c Using CP-Tagged $D \rightarrow K_{S,L}\pi\pi$ Decays

Eric White - University of Illinois Qing He - University of Rochester for the CLEO Collaboration Charm 07



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# Path to Measuring $\gamma/\varphi_3$

- Use  $B^{\pm} \rightarrow DK^{\pm}$  decays, followed by Dalitz plot analysis of  $D \rightarrow K_s \pi^+ \pi^-$ .
- Developed by Giri, Grossman, Soffer, Zupan (GGSZ)[1] / Belle [2] -- exploit interference between D<sup>0</sup> and D
  <sup>0</sup> channels



## Current $\gamma/\varphi_3$ Measurements

#### BaBar: $92^{\circ} \pm 41^{\circ}(\text{stat}) \pm 11^{\circ}(\text{syst}) \pm 12^{\circ}(\text{model})$ (211 fb<sup>-1</sup>)

BaBar Collaboration, B. Aubert et al. hep-ex/0607104

#### Belle: $53^{\circ} \pm 17^{\circ}(\text{stat}) \pm 3^{\circ}(\text{syst}) \pm 9^{\circ}(\text{model})$ (357 fb<sup>-1</sup>)

Belle Collaboration, A. Poluektov et al. Phys. Rev. D73 (2006)

Statistical uncertainty will go down to about ~  $6^{\circ}$  with projected 2 ab<sup>-1</sup> ( $r_{B} = 0.16$ )

(LHCb projects ~  $3^{\circ}-5^{\circ}$  uncertainty after 5 years...)

 $10^{\circ}$  model uncertainty will dominate  $\rightarrow$  CLEO-c can help lower this number

## Measuring $c_i$ with *CP*-tagged $K_S \pi \pi$ Dalitz Plots

Correlated  $D\overline{D}$  pairs (C = -1) are produced at CLEO-c We **tag** the  $K_s \pi \pi$  sample by reconstructing  $D \rightarrow CP \pm$  eigentstates

$$D_{CP\pm} = \frac{D^{\theta} \pm \overline{D^{\theta}}}{\sqrt{2}}$$

$$K_{S,L}\pi\pi$$

$$D \overline{D}$$

$$CP Tag$$

Ψ(3770

Binned Dalitz plot

π² (GeV²/c⁴) 5.2

For CP-tagged Dalitz plots, number of events in Dalitz plot is

$$M \sim |f_D|^2 + |\overline{f_D}|^2 \pm 2|f_D||\overline{f_D}| \cos(\delta_D)$$

Divide the  $(K_S \pi \pi)D$  Dalitz plot in to bins, symmetric under interchange of  $\pi^+ \leftrightarrow \pi^-$  interchange.

$$\begin{array}{c} \hline \text{Define} \rightarrow c_i = \langle \cos(\delta_D) \rangle_i \\ c_i \text{ can be determined by counting $CP$-tagged bins} \end{array} \\ c_i = \frac{1}{2} \frac{(\overline{M}_i^- - \overline{M}_i^+)}{(\overline{M}_i^- + \overline{M}_i^+)} \frac{(K_i + K_{\underline{-i}})}{\sqrt{K_i K_{-i}}} \underbrace{0.5}_{\underline{0}} \underbrace{0}_{\underline{0}} \underbrace{0.5 \ 1 \ 1.5 \ 2 \ 2.5 \ m_i^2 (\text{GeV})}_{\underline{m}_i^2 (\text{GeV})} \\ \hline \text{CP}\text{-tagged flavor-tagged} \end{array}$$

## **Tagged** $K_{S}\pi^{+}\pi^{-}$ **Data from CLEO-c**

We use 398 pb<sup>-1</sup> of correlated  $\Psi(3770) \rightarrow D\overline{D}$  decays Flavor-tagging modes:  $D^0 \rightarrow K^-\pi^+$ ,  $K^-\pi^+\pi^0$ ,  $K^-\pi^+\pi^-\pi^+$  (plus charge-conjugate)



# What about $K_L \pi \pi$ ?

- Why not use  $K_L \pi \pi$ ?
- Similar structure, opposite *CP*
- More than doubles overall statistics

# Tagged $K_L \pi^+ \pi^-$ Data

Use same flavor and *CP* tag modes as  $K_S \pi \pi$ , with same basic event selection



# *K*<sub>L</sub>π<sup>0</sup> vs. *K*<sub>S</sub>ππ

#### Additionally, we use $K_L \pi^0$ as *CP*-even tag for $K_S \pi \pi$ mode



# **CP-tagged** $K_S \pi^+ \pi^-$ Dalitz Plots



## **CP-tagged** $K_L \pi^+ \pi^-$ Dalitz Plots



# Flavor-tagged $K_{S,L}\pi^+\pi^-$ Dalitz Plots



Must take this into account before combining  $c_i$  measurements for  $K_L \pi \pi$  and  $K_S \pi \pi$  samples

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## Combining $c_i$ from $K_S \pi \pi$ and $K_L \pi \pi$

Define *r* as the magnitude of DCS/CF ratio

*r* is small (~ 0.06), but  
is the phase known? 
$$A(D^0 \rightarrow K_S \pi \pi) = K^{*-}(CF) + K^{*+}(DCS) + f_0 + \rho^0 + \dots$$

$$A(D^{0} \to K_{L}\pi\pi) = K^{*-}(CF(-K^{*+}(DCS) + (1-2re^{i?})f_{0} + (1-2re^{i?})\rho^{0} + \dots$$

Value of  $c_i$  is in general <u>different</u> for  $K_L \pi \pi$  and  $K_S \pi \pi$ , but can be related through U-spin symmetry

By varying each unknown phase and recalculating  $c_i$ , we can determine a measure of the systematic uncertainty for  $K_L \pi \pi$ 

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# **Binned Analysis**



# Comparing $c_i$ for $K_{S,L}\pi^+\pi^-$

- Obtain  $K_L \pi \pi$  model by changing sign of DCS terms  $\rightarrow K^{*+}(892), K^{*+}(1410)...$
- Calculate  $c_i$  from  $K_S \pi \pi$  and  $K_L \pi \pi$  models
- Vary phase for each resonance, keep largest difference in c<sub>i</sub>

- Systematic uncertainty from  $K_L \pi \pi$  is 'small compared to  $c_i$  difference
- Good agreement of *c<sub>i</sub>* difference in data



Λ

-0.2

**Bin Number** 

# Sensitivity to c<sub>i</sub>

- We combine  $K_L \pi \pi$ ,  $K_S \pi \pi$  Dalitz plots into an improved overall measurement of  $c_i$
- Scale statistical uncertainty up to full 750 pb<sup>-1</sup>
- Combine with  $K_L \pi \pi$  systematic uncertainty to determine overall expected sensitivity from CLEO-c measurement



0.8

 $c_i$  calculated from model

# Conclusion

- $K_L \pi \pi, K_S \pi \pi$  samples can be combined
- Good sensitivity to  $c_i$
- Total  $D_{CP}$  expected to be ~ 1,530 for 750 pb<sup>-1</sup>
- Combined BaBar/Belle (2 ab<sup>-1</sup>) statistical uncertainty  $\rightarrow \pm 6^{\circ}$
- CLEO-c can reduce model uncertainty from  $\pm 10^{\circ}$ down to  $\pm 4^{\circ}$  in  $\gamma/\varphi_3$  measurement



## **Back up**

Following modes will also be used to measure  $c_i$  and  $s_i$ 

 $\left. \begin{array}{c} K_{S}\pi\pi \text{ vs. } K_{S}\pi\pi (\sim 480) \\ K_{S}\pi\pi \text{ vs. } K_{L}\pi\pi (\sim 1240) \end{array} \right\} \text{ Expected yields (750 pb^{-1})}$